

Issue Classification				Application No.	Applicant(s)	
				10/701,501	YOON ET AL.	
				Examiner	Art Unit	
				Chad Rapp	2125	

ORIGINAL				CROSS REFERENCE(S)									
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
700	276												
INTERNATIONAL CLASSIFICATION													
G	0	5	B	13/00									
				/									
				/									
				/									
				/									
Chad Rapp 3/7/05 (Assistant Examiner) (Date)				LEO PICARD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 <i>L-P.P.</i> (Primary Examiner) (Date) 3/10/05								Total Claims Allowed: 4	
(Legal Instruments Examiner) (Date)												O.G. Print Claim(s) 1	O.G. Print Fig. 4

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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3		33		63		93	
4		34		64		94	
5		35		65		95	
6		36		66		96	
7		37		67		97	
8		38		68		98	
9		39		69		99	
10		40		70		100	
11		41		71		101	
12		42		72		102	
13		43		73		103	
14		44		74		104	
15		45		75		105	
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18		48		78		108	
19		49		79		109	
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21		51		81		111	
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24		54		84		114	
25		55		85		115	
26		56		86		116	
27		57		87		117	
28		58		88		118	
29		59		89		119	
30		60		90		120	